## UNITED STATES PATENT AND TRADEMARK OFFICE **CERTIFICATE OF CORRECTION**

PATENT NO.

: 6,946,039 B1

Page 1 of 1

APPLICATION NO.: 09/705101

: September 20, 2005

INVENTOR(S)

: Segal et al.

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Item (56) References Cited, Other Publications - Insert "R.Z. Valiev et al., "Plastic deformation of alloys with submicron-grained structure", Materials Science and Engineering, A137 (1991) pp. 35-40.

Column 3, line 47 - Replace "comprise" with --comprises--.

Column 4, line 40 - Replace "a an b" with --a and b--.

Column 12, line 12 - Replace "insure" with --ensure--.

Column 14, line 16 - After "can" insert --be--.

Column 14, line 56 - Replace "5h)" with --5h--.

Signed and Sealed this

Twenty-second Day of August, 2006

JON W. DUDAS Director of the United States Patent and Trademark Office